Issue Classification

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Application/Control No.	Applicant(s)/Patent Under Reexamination
09605293	CHAPEK, DAVID L.
Examiner	Art Unit
JAY C KIM	2815

ORIGINAL CLASS SUBCLASS							INTERNATIONAL CLASSIFICATION								ION	
							CLAIMED						NON-CLAIMED			
257			410			Н	0	1	L		21 / 02					
	CF	ROSS REF	ERENCE	(S)												
CLASS	SUE	BCLASS (ON	NE SUBCLAS	SS PER BLO	OCK)	†										
257	288	E21.423	E21.625	E21.639	E29.273											
257	E29.309															
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⋈	Claims renumbered in the same order as presented by applicant							t								
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final Original		
1	9															
2	10															
3	11															
4	12															
5	14															

NONE	Total Claims Allowed:					
(Assistant Examiner)	(Date)	5				
/JAY C KIM/ Primary Examiner.Art Unit 2815	6/5/12	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	2	Fig. 2			